IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Miyuki KAMOSHITA

Confirmation No. 6695

Serial No.:

10/551,903

Group Art Unit: 1772

Filed:

October 05, 2005

Examiner: unknown

FOR JAN 05 7006 AP3

METHOD OF PRODUCING GAS BARRIER MULTILAYER

BODY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Window, Mail Stop Amendment
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

Pursuant to 37 C.F.R. § 1.56 and 37 C.F.R. §§ 1.97-1.98, Applicant hereby directs the Examiner's attention to the following documents cited in the International Search Report for International Application PCT/JP2004/005173 of which the above-referenced application is a continuation:

- (1) JP 2004-35832 A, February 5, 2004, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan);
- (2) JP 2004-136281 A, May 13, 2004, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan);
- (3) JP 2004-137495 A, May 13, 2004, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is also a family member of document (2);
- (4) EP 1 548 074 A1, June 29, 2005; Applicant notes that this document is a family member of documents (2) and (3);

- (5) JP 2001-323204 A, November 22, 2001, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan);

 Applicant notes that this document is also cited and discussed at page 3, line 13 of the present application;
- (6) JP 2001-335736 A, December 4, 2001, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan);
- (7) JP 2003-49035 A, February 21, 2003, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan).

Furthermore, Applicant directs the Examiner's attention to the following documents cited and discussed in the present application:

- (8) JP 06-220221 A, August 9, 1994, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 9 of the present application;
- (9) U.S. Patent No. 5,552,479 (TANAKA et al.), September 3, 1996, Applicant notes that this document is a family member of document (8);
- (10) JP 07-102083 A, April 18, 1995, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 10 of the present application;
- (11) U.S. Patent No. 5,574,096 (TANAKA et al.), November 12, 1996;

 Applicant notes that this document is a family member of document (10);

- (12) JP 07-205379 A, August 8, 1995, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 11 of the present application;
- (13) U.S. Patent No. 5,560,988 (OBA et al.), October 1, 1996; Applicant notes that this document is a family member of document (12);
- (14) JP 07-266441 A, October 10, 1995, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 12 of the present application;
- (15) JP 08-041218 A, February 13, 1996, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 12 of the present application;
- (16) JP 10-237180 A, September 8, 1998, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 13 of the present application;
- (17) U.S. Patent No. 6,143,384 (TANAKA et al.), November 7, 2000; Applicant notes that this document is a family member of document (16);
- (18) U.S. Patent No. 6,022,913 (TANAKA et al.), February 8, 2000; Applicant notes that this document is a family member of documents (16) and (17);

- (19) JP 2000-000931 A, January 7, 2000, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 2, line 14 of the present application;
- (20) U.S. Patent No. 6,605,344 B1 (OHBA et al.), August 12, 2003; Applicant notes that this document is a family member of document (19);
- (21) JP 2002-020677 A, January 23, 2002, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 3, line 14 of the present application;
- (22) JP 2002-241671 A, August 28, 2002, accompanied by an English language abstract thereof (provided by Patent Abstracts of Japan); Applicant notes that this document is cited and discussed at page 3, line 15 of the present application.

Copies of the above-listed documents (with the exception of U.S. patents and U.S. patent applications) and the International Search Report for International Application PCT/JP2004/005173 are enclosed together with a completed copy of the PTO-1449 Form listing these documents. Accordingly, the Examiner is requested to consider these documents and to indicate such consideration by returning a signed and initialed copy of the PTO-1449 Form with the next official communication.

P28626.A03

Further to the U.S. Patent and Trademark Office's decision to partially waive the requirements under 37 C.F.R. § 1.98 (a)(2)(i) and (iii), copies of the U.S. patents and U.S. patent applications cited above are not enclosed herewith. However, if any copies are needed, the Examiner is respectfully requested to contact the undersigned.

Applicant notes that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material.

If there should be any questions, the Examiner is invited to contact the undersigned at the telephone number listed below.

Respectfully submitted, Miyuki KAMOSHITA

Bruce H. Bernstein

Reg. No. 29,027

Stephen M. Roylance Reg. No. 31,296

January 5, 2006 GREENBLUM & BERNSTEIN P.L.C. 1950 Roland Clarke Place Reston, VA 20191 (703) 716 1191

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EXAMINER DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.